

<b>Notice of References Cited</b>	Application/Control No. 10/550,550		Applicant(s)/Patent Under Reexamination NONOYAMA ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,661,811 A	04-1987	Gray et al.	345/636
*	B	US-4,825,232 A	04-1989	Howdle, William J.	396/12
*	C	US-5,200,902 A	04-1993	Pilley, Harold R.	701/120
*	D	US-5,483,865 A	01-1996	Brunand, Jacques	89/41.21
*	E	US-5,589,901 A	12-1996	Means, Kevin P.	396/12
*	F	US-5,818,951 A	10-1998	Schivley, James Dale	382/100
*	G	US-2001/0036295 A1	11-2001	Hendrickson et al.	382/110
*	H	US-2002/0163582 A1	11-2002	Gruber et al.	348/218.1
*	I	US-6,535,816 B1	03-2003	Smith, Patrick Lawrence	701/213
*	J	US-6,529,615 B2	03-2003	Hendrickson et al.	382/110
*	K	US-6,584,382 B2	06-2003	Karem, Abraham E.	701/3
*	L	US-2003/0220734 A1	11-2003	Harrison et al.	701/208
*	M	US-6,653,990 B1	11-2003	Lestruhaut, Olivier	345/8

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

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	U	
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	X	

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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0218675 A1	11-2003	Nonoyama, Yasumasa	348/144
*	B	US-6,694,064 B1	02-2004	Benkelman, Cody	382/284
*	C	US-6,738,859 B2	05-2004	Liebchen, Armin	716/19
*	D	US-6,766,226 B2	07-2004	Andersen, Dan Keith	701/3
*	E	US-6,822,742 B1	11-2004	Kalayeh et al.	356/437
*	F	US-6,925,382 B2	08-2005	Lahn, Richard H.	701/223
*	G	US-2005/0278087 A1	12-2005	Lahn, Richard H.	701/023
*	H	US-2006/0075356 A1	04-2006	Faulkner et al.	715/782
*	I	US-2006/0215027 A1	09-2006	Nonoyama et al.	348/144
*	J	US-7,186,978 B2	03-2007	Bevan et al.	250/330
*	K	US-7,236,613 B2	06-2007	Murata, Ronald N.	382/103
*	L	US-2007/0285663 A1	12-2007	Hewitt et al.	356/399
*	M	US-2008/0074494 A1	03-2008	Nemethy et al.	348/143

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,358,498 B2	04-2008	Geng et al.	250/347
*	B	US-7,411,196 B2	08-2008	Kalayeh, Hooshmand M.	250/342
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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